

Current-induced magnetoresistance oscillations in two-dimensional electron systems

X. L. Lei

Department of Physics, Shanghai Jiaotong University, 1954 Huashan Road, Shanghai 200030, China

Electric current-induced magnetoresistance oscillations recently discovered in two-dimensional electron systems are analyzed using a microscopic scheme for nonlinear magnetotransport direct controlled by the current. The magnetoresistance oscillations are shown to result from drift-motion assisted electron scatterings between Landau levels. The theoretical predictions not only reproduce all the main features observed in the experiments but also disclose other details of the phenomenon.

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The effect of a strong dc on magnetoresistance has long been an outstanding problem in transport in two-dimensional (2D) electron systems (ESs). In the case of microwave-induced magnetoresistance oscillations,^{1,2,3,4,5,6,7} a finite dc has been shown to suppress the oscillation and eliminate the negative resistance existing in the weak current limit.^{8,9} Quite surprisingly, in the case without microwave, a relatively weak dc can induce substantial magnetoresistance oscillations in 2DESs.

The current-induced magnetoresistance oscillations (CIMO) were observed in differential magnetoresistance in high-mobility Hall-bar specimens.¹⁰ The oscillation is periodic in inverse magnetic field and its period is tunable by the current density. This discovery was later confirmed in highly doped samples and the differential resistance oscillating with changing current density at fixed magnetic field was also detected.¹¹ Measurements were recently reported at higher temperatures¹² and careful studies in ultrahigh mobility samples were carried out.¹³

In this Letter we show that all these observed CIMOs can be well explained with the microscopic balance-equation scheme for hot-electron magnetotransport direct controlled by the current.^{14,15,16,17}

We consider a 2D system consisting of N_s electrons in a unit area of the x - y plane. These electrons, interacting with each other, are scattered by random impurities and by phonons in the lattice. There are a uniform magnetic field $\mathbf{B} = (0, 0, B)$ along the z direction and a uniform electric field \mathbf{E} in the x - y plane. The nonlinear steady state magnetotransport of this system can be described in terms of the center of mass and relative electron variables^{14,15,16} by the following force and energy-balance equations:¹⁷

$$N_s e \mathbf{E} + N_s e (\mathbf{v} \times \mathbf{B}) + \mathbf{f}(\mathbf{v}) = 0, \quad (1)$$

$$\mathbf{v} \cdot \mathbf{f}(\mathbf{v}) + w(\mathbf{v}) = 0. \quad (2)$$

Here $\mathbf{f}(\mathbf{v}) = \mathbf{f}_i(\mathbf{v}) + \mathbf{f}_p(\mathbf{v})$ is the frictional forces due to impurity and phonon scatterings, with the impurity part

$$\mathbf{f}_i(\mathbf{v}) = \sum_{\mathbf{q}_{\parallel}} \mathbf{q}_{\parallel} |U(\mathbf{q}_{\parallel})|^2 \Pi_2(\mathbf{q}_{\parallel}, \mathbf{q}_{\parallel} \cdot \mathbf{v}), \quad (3)$$

$$w(\mathbf{v}) = \sum_{\mathbf{q}} \Omega_{\mathbf{q}} |M(\mathbf{q})|^2 \Lambda_2(\mathbf{q}, \Omega_{\mathbf{q}} + \mathbf{q}_{\parallel} \cdot \mathbf{v}) \quad (4)$$

is the electron energy-loss rate to the lattice. In these expressions, $U(\mathbf{q}_{\parallel})$ and $M(\mathbf{q})$ stand for effective impurity and phonon scattering potentials, $\Pi_2(\mathbf{q}_{\parallel}, \Omega)$ is the imaginary part of the electron density-correlation function at electron temperature T_e in the magnetic field, and function $\Lambda_2(\mathbf{q}, \Omega) \equiv 2 \Pi_2(\mathbf{q}_{\parallel}, \Omega) [n(\Omega_{\mathbf{q}}/T) - n(\Omega/T_e)]$ ($n(x) \equiv 1/(e^x - 1)$), also relevant to phonon emission and absorption. The effect of interparticle Coulomb interactions is included in the Π_2 function to the degree of electron level broadening and screening. The remaining $\Pi_2(\mathbf{q}_{\parallel}, \Omega)$ function is that of a 2D electron gas in a magnetic field, which can be written in the Landau representation as:¹⁴

$$\Pi_2(\mathbf{q}_{\parallel}, \Omega) = \frac{1}{2\pi l_B^2} \sum_{n, n'} C_{n, n'} (l_B^2 q_{\parallel}^2 / 2) \Pi_2(n, n', \Omega), \quad (5)$$

$$\begin{aligned} \Pi_2(n, n', \Omega) = & -\frac{2}{\pi} \int d\varepsilon [f(\varepsilon) - f(\varepsilon + \Omega)] \\ & \times \text{Im} G_n(\varepsilon + \Omega) \text{Im} G_{n'}(\varepsilon), \end{aligned} \quad (6)$$

where $l_B = \sqrt{1/|eB|}$ is the magnetic length, $C_{n, n+l}(Y) \equiv n![(n+l)!]^{-1} Y^l e^{-Y} [L_n^l(Y)]^2$ with $L_n^l(Y)$ the associate Laguerre polynomial, $f(\varepsilon) = \{\exp[(\varepsilon - \mu)/T_e] + 1\}^{-1}$ is the Fermi function at electron temperature T_e , and $\text{Im} G_n(\varepsilon)$ is the density of states (DOS) of the broadened LL n .

We model the DOS function with a Gaussian-type form for both overlapped and separated LLs ($\varepsilon_n = n\omega_c$ is the center energy of the n th LL and $\omega_c = eB/m$ is the cyclotron frequency):¹⁸

$$\text{Im} G_n(\varepsilon) = -(2\pi)^{\frac{1}{2}} \Gamma^{-1} \exp[-2(\varepsilon - \varepsilon_n)^2 / \Gamma^2] \quad (7)$$

with a magnetic field $B^{1/2}$ dependent half width $\Gamma = (8\alpha e \omega_c / \pi m \mu_0)^{1/2}$ expressed in terms of μ_0 , the linear mobility at lattice temperature T in the absence of the magnetic field, together with a broadening parameter α to take account of the difference between the transport scattering time and the broadening-related quantum lifetime.^{4,7} We will also use a B -independent Γ for comparison.

Equations (1) and (2) are quite general, applicable to current-control magnetotransport in any configuration. For an isotropic system where the frictional force is in the opposite direction of the drift velocity, we can write

$\mathbf{f}(\mathbf{v}) = f(v)\mathbf{v}/v$ and $w(\mathbf{v}) = w(v)$. In the Hall configuration with the velocity \mathbf{v} in the x direction $\mathbf{v} = (v, 0, 0)$ or the current densities $J_x = N_s e v$ and $J_y = 0$, Eq. (1) yields the transverse and longitudinal resistivities

$$R_{xy} = E_y/J_x = B/N_s e, \quad (8)$$

$$R_{xx} = E_x/J_x = -f(v)/(N_s e^2 v), \quad (9)$$

and the longitudinal differential resistivity

$$r_{xx} = -(\partial f(v)/\partial v)/(N_s e^2). \quad (10)$$

Equation (8) confirms the relation $E_y = B J_x / N_s e$ in the Hall configuration of nonlinear magnetotransport even with an intense dc flowing in the x direction.

Expressions (9) and (10) are particularly convenient to deal with current-induced phenomena. Apparently, the velocity v , or the current J_x , can affect R_{xx} and r_{xx} through the $\mathbf{q}_{\parallel} \cdot \mathbf{v}$ factor in the $\Pi_2(\mathbf{q}_{\parallel}, \mathbf{q}_{\parallel} \cdot \mathbf{v})$ function. Eqs. (5) and (6) indicate that in the case of low electron temperature ($T_e \ll \epsilon_F$, the Fermi level) and many Landau-level occupation, $\Pi_2(\mathbf{q}_{\parallel}, \Omega)$ is essentially a periodical function, i.e. $\Pi_2(\mathbf{q}_{\parallel}, \Omega + \omega_c) = \Pi_2(\mathbf{q}_{\parallel}, \Omega)$. Therefore, the impurity-induced resistivity R_{xx} would exhibit periodical oscillations when changing drift velocity v or changing magnetic field $1/B$. We introduce a frequency-dimension quantity $\omega_j \equiv 2k_F v$ to trace the change of the drift velocity v or the current $J_x = N_s e v$, and use the dimensionless ratio

$$\frac{\omega_j}{\omega_c} = \frac{2mk_F v}{eB} = \sqrt{\frac{8\pi}{N_s}} \frac{m}{e^2} \frac{J_x}{B} \quad (11)$$

as the control parameter to demonstrate this oscillation, which exhibits an approximate periodicity $\Delta(\omega_j/\omega_c) \sim 1$.

In addition to the effect discussed above, a finite current J_x may heat the electrons and can also affect the longitudinal resistivity through the electron-temperature change in the Π_2 function. Giving the drift velocity v or the current $J_x = N_s e v$, the electron temperature T_e is easily determined by the energy-balance equation (2), $w(v) + v f(v) = 0$, and the longitudinal resistivity is then obtained directly from Eq. (9).

For GaAs-based high-mobility 2DESs at low temperatures, the dominant direct contribution to the resistivity comes from impurity scatterings and f_p is negligible. To obtain the electron energy dissipation rate w needed for determining the electron heating, we consider scatterings from bulk longitudinal and transverse acoustic phonons, as well as from polar optical phonons with coupling parameters taken as typical values of n -type GaAs,¹⁶ having an electron effective mass $m = 0.067 m_e$ (m_e is the free electron mass).

Figure 1(a) presents the calculated resistivity R_{xx} and differential resistivity r_{xx} versus the inverse magnetic field $1/B$ in terms of ω_j/ω_c at lattice temperature $T = 1$ K, for a 2D system with electron density $N_s = 3.0 \times 10^{15} \text{ m}^{-2}$ and linear mobility $\mu_0 = 2000 \text{ m}^2/\text{Vs}$ subject to three different bias dc current densities $J_x = 0.40, 0.68$

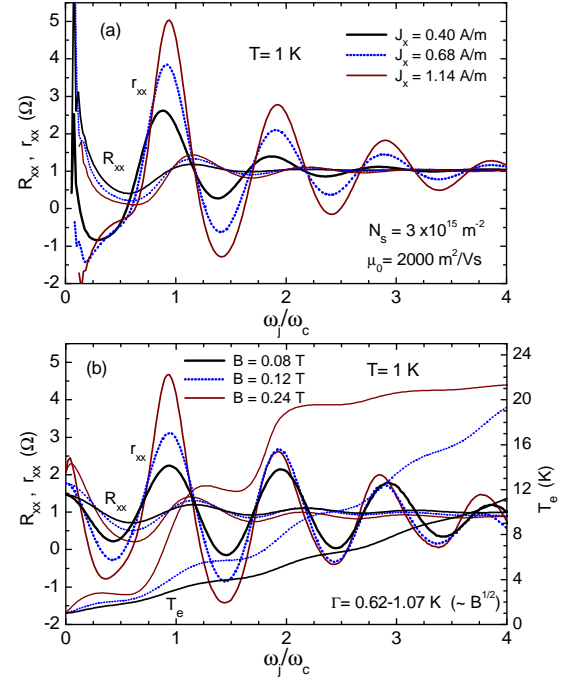


FIG. 1: (Color online) (a) Resistivity R_{xx} and differential resistivity r_{xx} versus ω_j/ω_c at fixed DC current density $J_x = 0.40, 0.68$ or 1.14 A/m , and (b) R_{xx} , r_{xx} and electron temperature T_e versus ω_j/ω_c at fixed magnetic field $B = 0.08, 0.12$ or 0.24 T , for a GaAs-based 2D system having electron density $N_s = 3.0 \times 10^{15} \text{ m}^{-2}$, linear mobility $\mu_0 = 2000 \text{ m}^2/\text{Vs}$, $\alpha = 10$ at $T = 1 \text{ K}$, assuming SR scattering.

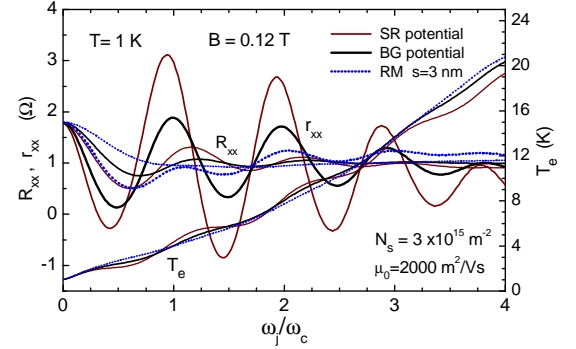


FIG. 2: (Color online) R_{xx} , r_{xx} and T_e versus ω_j/ω_c at fixed magnetic field $B = 0.12 \text{ T}$ for the same system as described in Fig. 1 but subject to SR, BG or RM scattering potentials.

and 1.14 A/m , which correspond to $\omega_j/2\pi = 32.3, 62.2$ and 103.6 GHz respectively. The elastic scattering is assumed to be short ranged, and the broadening parameter $\alpha = 10$, i.e. $B^{1/2}$ -dependent Γ , $\simeq 0.62 \text{ K}$ at $B = 0.08 \text{ T}$. Oscillations in resistivity R_{xx} , especially in differential resistivity r_{xx} show up remarkably, having an approximate period $\Delta(\omega_j/\omega_c) \sim 1$. The oscillation amplitude decays with increasing ω_j/ω_c (reducing B field, due to increasing overlap of LLs) at fixed bias current but increases with increasing bias current density within the J_x range shown. The maxima (minima) of the differential resistiv-

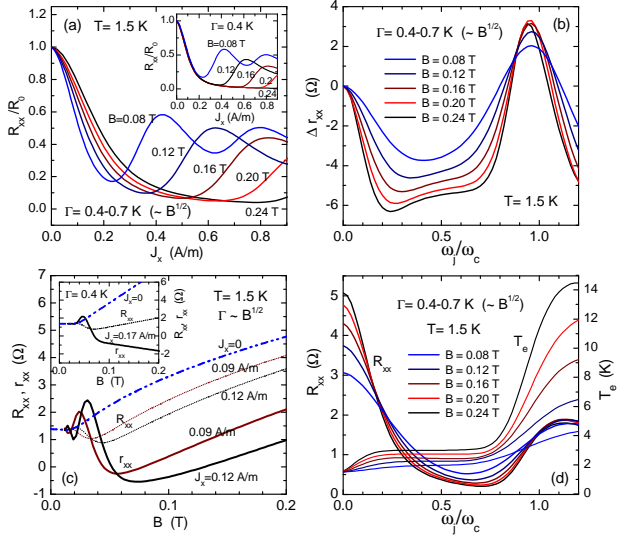


FIG. 3: (Color online) Calculated R_{xx} , r_{xx} , R_{xx}/R_0 , $\Delta r_{xx} = r_{xx} - R_0$ and T_e for a GaAs-based 2D system with $N_s = 3.0 \times 10^{15} \text{ m}^{-2}$ at lattice temperature $T = 1.5 \text{ K}$ subject to a mixed SR and BG elastic scattering. The LL width is taken to be $B^{1/2}$ dependent with $\Gamma = 0.4 \text{ K}$ at $B = 0.08 \text{ T}$. The insets illustrate the case of fixed LL width $\Gamma = 0.4 \text{ K}$.

ity r_{xx} locate quite close to (but somewhat lower than) the integers (half integers) of ω_j/ω_c , while the maxima (minima) of the total resistivity R_{xx} are shifted around a quarter period higher. These features are in good agreement with recent experimental findings.¹³ Note that the electron temperature T_e (not shown) exhibits only a weak variation with changing B field at each fixed dc.

In Fig.1(b) we plot R_{xx} , r_{xx} and electron temperature T_e versus the dc density in terms of ω_j/ω_c at fixed magnetic fields $B = 0.08, 0.12$ and 0.24 T for the same system. Remarkable R_{xx} and r_{xx} oscillations with approximate period $\Delta(\omega_j/\omega_c) \sim 1$ and maxima (minima) positions similar to those in Fig.1(a) can be seen in this current-sweeping figure but here the oscillation decay with increasing ω_j/ω_c is due to increase in the electron temperature. At lower ω_j/ω_c range, the oscillation amplitude of high B -field case is apparently larger than low B -field case when the electron temperature T_e is still in the range less than or around 10 K . However, in the case of $B = 0.24 \text{ T}$ the oscillation amplitude decays rapidly with increasing ω_j/ω_c due to the rapid increase of electron temperature, which rises up to 20 K range around $\omega_j/\omega_c = 2$. In comparison, the amplitude decay is much slower in the case of $B = 0.08 \text{ T}$ because of the slow T_e rise. Furthermore, the periods of R_{xx} and r_{xx} oscilla-

tions are also somewhat shrunk by the rise of T_e , as can be seen at higher orders in the $B = 0.24 \text{ T}$ case.

Note that though the periods of these resistance oscillations are roughly the same in terms of ω_j/ω_c , their amplitude and the detailed behavior depend strongly on the form of the scattering potential $U(\mathbf{q}_{\parallel})$ in Eq. (3). To have an idea of this scattering potential effect we plot, in Fig. 2, R_{xx} , r_{xx} , and T_e as functions of ω_j/ω_c at a fixed magnetic field $B = 0.12 \text{ T}$ for the same 2D system but with the dominant elastic scatterings, respectively, due to short-range (SR) disorder, charged impurities in the background (BG), or ionized impurities locating a distance $s = 3 \text{ nm}$ away from the 2D sheet (RM).¹⁶ R_{xx} and r_{xx} exhibit the strongest oscillations in the case of SR potential, with a feature that the second minimum of r_{xx} goes deeper into negative direction than the first minimum. In the case of BG scattering R_{xx} and r_{xx} oscillations, though weaker than those of SR-scattering case, still appear quite substantial and the first minimum of r_{xx} turns out to be the deepest one of all minima. In the case of RM ($s = 3 \text{ nm}$) scattering, these current-induced resistance oscillations, though existing, become much weaker than those of SR and BG scatterings.

Fig.3 presents the calculated R_{xx} , r_{xx} , R_{xx}/R_0 , $\Delta r_{xx} = r_{xx} - R_0$ (R_0 is the resistivity at zero dc bias) and T_e , for another GaAs-based 2D system with $N_s = 3.0 \times 10^{15} \text{ m}^{-2}$, $\mu_0 = 1500 \text{ m}^2/\text{Vs}$ at $T = 1.5 \text{ K}$, focusing on the first oscillation period of ω_j/ω_c . The elastic scatterings are assumed due to a mixture of SR and BG impurities (with 2:1 contribution ratio to the linear mobility).¹⁶ The broadening parameter is taken to be $\alpha = 3$ ($B^{1/2}$ -dependent Γ , $\simeq 0.4 \text{ K}$ at $B = 0.08 \text{ T}$), a somewhat smaller LL width to keep the system mainly in the separated LL regime. The insets of Figs.3a and 3c show the results using a B -independent $\Gamma = 0.4 \text{ K}$. All the main features found in the experiment in the case of separated Landau levels,¹³ e.g., the dramatic initial suppression of the magnetoresistivity with increasing dc density, the widening and deepening of the first minimum range with increasing B field, a few resolvable oscillations of r_{xx} at lower B , dramatic reduction of it at higher magnetic field, etc., are well reproduced. Note that the width of the half zero-bias peak in terms of ω_j accurately reflects the width of LLs, as can be seen clearly in Fig. 3(a) and its inset. This suggests an ideal way to determine the width of LLs.

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